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|-----------------------------------|---------------------------------------|--|-------------|
| <b>Notice of References Cited</b> | Application/Control No.<br>10/729,919 | Applicant(s)/Patent Under<br>Reexamination<br>HSIANG, YUEH WEN |             |
|                                   | Examiner<br>Kimnhung Nguyen           | Art Unit<br>2629   | Page 1 of 1 |

**U.S. PATENT DOCUMENTS**

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name                | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-2003/0011576                                  | 01-2003         | Sandbach et al.     | 345/173        |
| * | B | US-5,565,657                                     | 10-1996         | Merz, Eric A.       | 178/18.01      |
| * | C | US-5,724,064                                     | 03-1998         | Stefik et al.       | 345/105        |
| * | D | US-2003/0107556                                  | 06-2003         | Yamashita, Shunichi | 345/173        |
| * | E | US-2004/0027340                                  | 02-2004         | Muraoka et al.      | 345/173        |
| * | F | US-2003/0206161                                  | 11-2003         | Liu et al.          | 345/173        |
| * | G | US-2003/0071796                                  | 04-2003         | Nakanishi et al.    | 345/173        |
|   | H | US-  |                 |                     |                |
|   | I | US-  |                 |                     |                |
|   | J | US-  |                 |                     |                |
|   | K | US-  |                 |                     |                |
|   | L | US-  |                 |                     |                |
|   | M | US-  |                 |                     |                |

**FOREIGN PATENT DOCUMENTS**

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
|   | N |  |                 |         |      |                |
|   | O |  |                 |         |      |                |
|   | P |  |                 |         |      |                |
|   | Q |  |                 |         |      |                |
|   | R |  |                 |         |      |                |
|   | S |  |                 |         |      |                |
|   | T |  |                 |         |      |                |

**NON-PATENT DOCUMENTS**

| * |   | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
|   | U |   |
|   | V |   |
|   | W |   |
|   | X |   |

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